## **CLAIMS**

## What is claimed is:

- 1. A resist removal method comprising: providing a substrate having a surface; forming resist on at least a portion of the surface; and providing a laser to remove the resist from the substrate.
- 2. The method according to claim 1 wherein said laser includes a laser associated with an automolding system.
- 3. The method according to claim 1 wherein said laser comprises one of an Nd:YAG laser and an excimer laser.
- 4. The method according to claim 1 wherein said substrate comprises a ball-grid-array substrate.
- 5. The method according to claim 1 further comprising a vision system for detecting resist.
- 6. The method according to claim 5 wherein said vision system comprises: providing a laser scanning system; detecting changes in the pattern of the substrate.
- 7. A semiconductor device formed by a laser etching process comprising: providing a substrate having a surface; forming resist on at least a portion of the surface; and etching the resist from the surface cf the substrate using a laser.

- 8. The method according to claim 7 wherein said laser comprises a laser associated with an automolding system.
- 9. The method according to claim 7 wherein said laser includes one of an Nd:YAG laser and an excimer laser.
- 10. The method according to claim 7 wherein said substrate comprises a ball-grid-array substrate.
- 11. The method according to claim 7 further comprising a vision system for detecting resist.
- 12. The method according to claim 11 wherein said vision system comprises: providing a laser scanning system; detecting changes in the pattern of the substrate.
- 13. A method of fabricating a semiconductor device comprising: providing a substrate having a surface; forming resist on at least a portion of the surface; laser etching the resist from the surface of the substrate; and encapsulating the substrate.
- 14. The method according to claim 13 wherein said laser comprises a laser associated with an automolding system.
- 15. The method according to claim 13 wherein said laser comprises one of an Nd:YAG laser and an excimer laser.
- 16. The method according to claim 13 wherein said substrate comprises a ball-grid-array substrate.

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- 17. The method according to claim 13 further comprising a vision system for detecting resist.
- 18. The method according to claim 17 wherein said vision system comprises: providing a laser scanning system; detecting changes in the pattern of the substrate.
- 19. A method of enhancing the adhesion of a compound to a surface of a substrate comprising:
  providing a substrate having a surface;
  roughening the surface of the substrate.
- 20. The method according to claim 21 wherein said roughening comprises removing contamination and foreign particles from said surface of the substrate.
- 21. An automolding system comprising: providing a substrate having a surface; preheating the substrate; forming a resist layer; baking the substrate; and removing contaminants from the substrate using a laser.
- 22. The automolding system of claim 21 wherein said laser comprises one of an Nd:YAG laser and an excimer laser.
- 23. The automolding system of claim 21 further comprising: placing the substrate in a mold; and encapsulating the substrate.

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